Unit: mm

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSIV)

TPCA8103

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

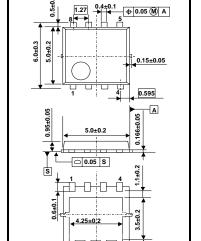
- · Small footprint due to small and thin package
- Low drain-source ON resistance: RDS (ON) = $3.1 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 45S$ (typ.)
- Low leakage current: $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -30 \text{ V)}$
- Enhancement mode: $V_{th} = -0.8 \text{ to } -2.0 \text{ V (V}_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-30	V	
Drain-gate voltage (R	$k_{GS} = 20 \text{ k}\Omega$	V_{DGR}	-30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	- 40	Α	
Diam current	Pulsed (Note 1)	I_{DP}	-120		
Drain power dissipati	on (Tc=25°C)	P_{D}	45	W	
Drain power dissipation	on (t = 10 s) (Note 2a)	P_{D}	2.8	W	
Drain power dissipation	on (t = 10 s) (Note 2b)	P_{D}	1.6	W	
Single pulse avalanch	ne energy (Note 3)	EAS	208	mJ	
Avalanche current		I _{AR}	- 40	Α	
Repetitive avalanche	energy c=25°C) (Note 4)	E _{AR}	4.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	

Note: For (Note 1), (Note 2), (Note 3), (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.



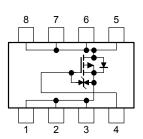
TOSHIBA 2-5Q1A

Weight: 0.076 g (typ.)

JEDEC JEITA

1,2,3 : SOURCE 4 : GATE 5,6,7,8 : DRAIN

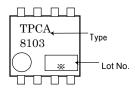
Circuit Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	78.1	°C/W

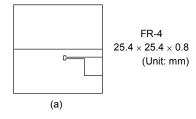
Marking (Note 5)

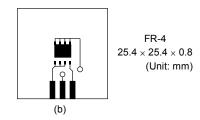


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)





Note 3: $V_{DD}=24~V$, $T_{ch}=25^{\circ}C$ (initial), $L=100\mu H$, $R_{G}=25~\Omega$, $I_{AR}=-40~A$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: O on lower left of the marking indicates Pin 1.

Weekly code: (Three digits)

Week of manufacture
(01 for first week of year, continues up to 52 or 53)

Year of manufacture
(One low-order digits of calendar year)

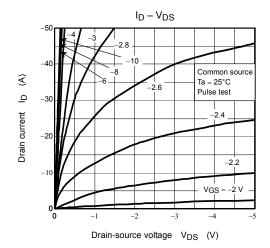
Electrical Characteristics (Ta = 25°C)

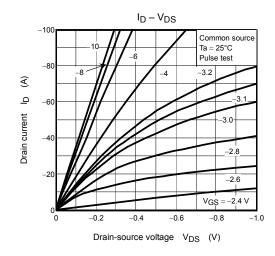
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_		±10	μА
Drain cut-OFF cu	rrent	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	— — — — — — — — — — — — — — — — — — —		μА	
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30	_	_	V
Diani-source brea	akdown voltage	V _{(BR)DSX}	$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-13	-13 — -0.8 — -2.0 — 5.2 6.8 — 3.1 4.2 22.5 45 — 7880 — 1340 — 1450		V
Gate threshold vo	ltage	V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8 — -2		-2.0	V
Drain-source ON resistance		Pro (OLI)	$V_{GS} = -4 \text{ V}, I_D = -20 \text{ A}$	_	5.2	6.8	mΩ
Diain-source ON	resistance	R _{DS} (ON)	$V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$	_	3.1	4.2	11122
Forward transfer admittance		Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -20 \text{ A}$	22.5	45	_	S
Input capacitance		C _{iss}		_	7880	_	pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	1340	_	
Output capacitance		C _{oss}		_	1450	_	
Reverse transfer ca	Rise time	t _r	V _{GS} 0 V 1 _D = -20A	_	15	_	ns
	Turn-ON time	t _{on}		_	13	_	
	Fall time	t _f	4.7.5 W W W W W W W W W W W W W W W W W W W	_	251	_	
	Turn-OFF time	t _{off}	$V_{DD} \simeq -15 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \text{ μs}$	_	596	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq -24 \text{ V}, V_{GS} = -10 \text{ V},$ $I_D = -40 \text{ A}$		184		nC
Gate-source charge 1		Q _{gs1}			12		
Gate-drain ("miller") charge		Q _{gd}		_	58		

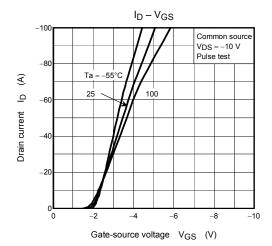
Source-Drain Ratings and Characteristics (Ta = 25°C)

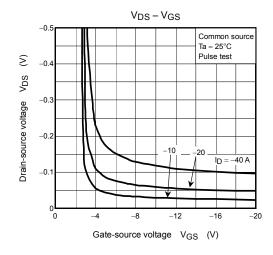
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	-120	Α
Forward voltage (diode)			V_{DSF}	$I_{DR} = -40 \text{ A}, V_{GS} = 0 \text{ V}$		_	1.2	V

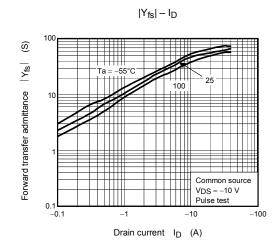
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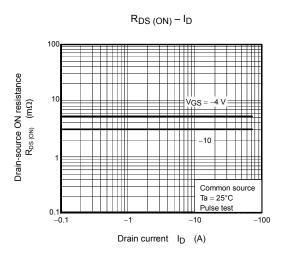




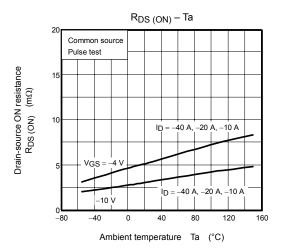


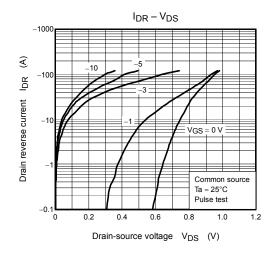


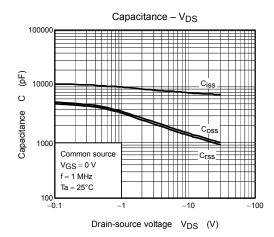


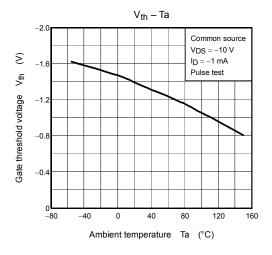


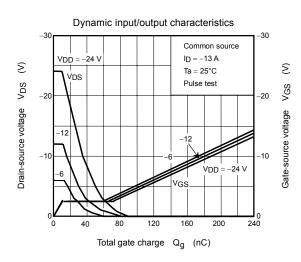
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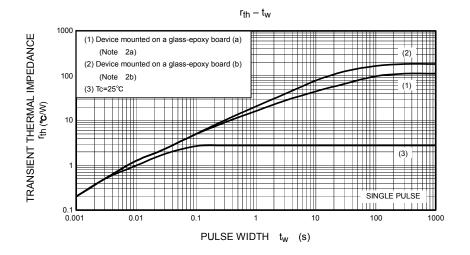


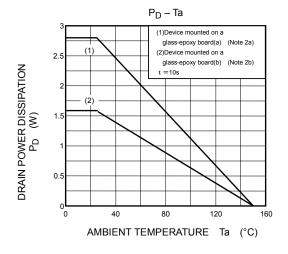


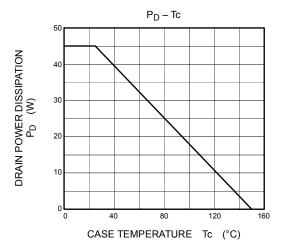


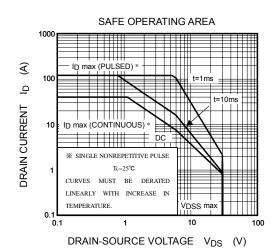


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